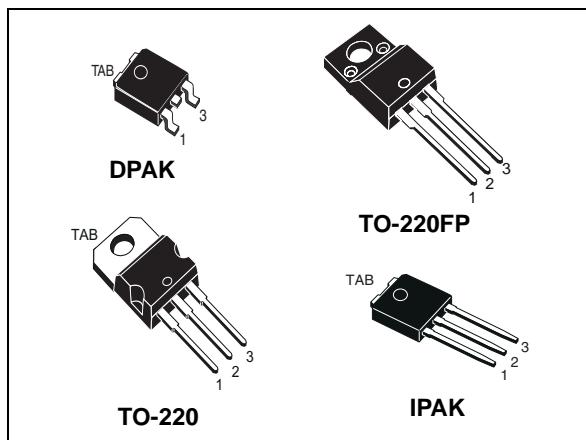


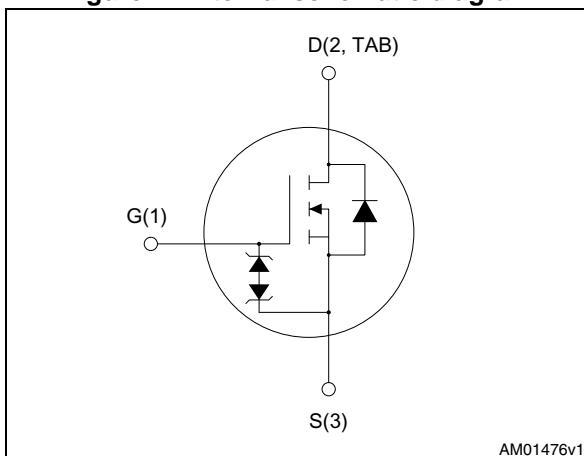
# STD4N80K5, STF4N80K5, STP4N80K5, STU4N80K5

N-channel 800 V, 2.1 Ω typ., 3 A MDmesh™ K5 Power MOSFETs  
in DPAK, TO-220FP, TO-220 and IPAK packages

Datasheet - production data



**Figure 1. Internal schematic diagram**



## Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	P <sub>TOT</sub>
STD4N80K5	800 V	2.5 Ω	3 A	60 W
STF4N80K5				20 W
STP4N80K5				
STU4N80K5				60 W

- Industry's lowest R<sub>DS(on)</sub> x area
- Industry's best figure of merit (FoM)
- Ultra low gate charge
- 100% avalanche tested
- Zener-protected

## Applications

- Switching applications

## Description

These very high voltage N-channel Power MOSFETs are designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

**Table 1. Device summary**

Order code	Marking	Packages	Packaging
STD4N80K5	4N80K5	DPAK	Tape and reel
STF4N80K5		TO-220FP	Tube
STP4N80K5		TO-220	
STU4N80K5		IPAK	

## Contents

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# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value			Unit
		DPAK, IPAK	TO-220FP	TO-220	
$V_{DS}$	Drain-source voltage	800			V
$V_{GS}$	Gate- source voltage	$\pm 30$			V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	3	3 <sup>(1)</sup>	3	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	1.7	1.7 <sup>(1)</sup>	1.7	A
$I_{DM}^{(2)}$	Drain current (pulsed)	12	12 <sup>(1)</sup>	12	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	60	20	60	W
$I_{AR}$	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_J$ max)	1			A
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25^\circ\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 50$ V)	74.5			mJ
$dv/dt^{(3)}$	Peak diode recovery voltage slope	4.5			V/ns
$dv/dt^{(4)}$	MOSFET dv/dt ruggedness	50			V/ns
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t = 1$ s, $T_C = 25^\circ\text{C}$ )		2500		V
$T_J$	Operating junction temperature	-55 to 150			$^\circ\text{C}$
$T_{stg}$	Storage temperature				$^\circ\text{C}$

1. Limited by maximum junction temperature
2. Pulse width limited by safe operating area
3.  $I_{SD} < 3$  A,  $di/dt < 100$  A/ $\mu\text{s}$ ,  $V_{DS(\text{peak})} \leq V_{(\text{BR})DSS}$
4.  $V_{DS} \leq 640$  V

Table 3. Thermal data

Symbol	Parameter	Value			Unit
		DPAK, IPAK	TO-220FP	TO-220	
$R_{thj-case}$	Thermal resistance junction-case max	2.08	6.25	2.08	$^\circ\text{C/W}$
$R_{thj-amb}$	Thermal resistance junction-ambient max		62.5		$^\circ\text{C/W}$
$R_{thj-pcb}^{(1)}$	Thermal resistance junction-pcb max	50			$^\circ\text{C/W}$

1. When mounted on 1inch<sup>2</sup> FR-4 board, 2 oz Cu

## 2 Electrical characteristics

(T<sub>case</sub> =25 °C unless otherwise specified)

**Table 4. On /off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	800			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 800 V			1	μA
		V <sub>DS</sub> = 800 V, T <sub>C</sub> =125 °C			50	μA
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			±10	μA
V <sub>GS(th)</sub>	Gate threshold voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 100 μA	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.5 A		2.1	2.5	Ω

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C <sub>iss</sub>	Input capacitance	V <sub>DS</sub> = 100 V, f = 1 MHz, V <sub>GS</sub> = 0	-	175	-	pF
C <sub>oss</sub>	Output capacitance		-	18	-	pF
C <sub>rss</sub>	Reverse transfer capacitance		-	0.5	-	pF
C <sub>o(tr)<sup>(1)</sup></sub>	Equivalent capacitance time related	V <sub>DS</sub> = 0 to 640 V, V <sub>GS</sub> = 0	-	26	-	pF
C <sub>o(er)<sup>(2)</sup></sub>	Equivalent capacitance energy related	V <sub>DS</sub> = 0 to 640 V, V <sub>GS</sub> = 0	-	11	-	pF
R <sub>g</sub>	Gate input resistance	f=1 MHz, I <sub>D</sub> = 0	-	15	-	Ω
Q <sub>g</sub>	Total gate charge	V <sub>DD</sub> = 640 V, I <sub>D</sub> = 3 A, V <sub>GS</sub> = 10 V <i>(see Figure 19)</i>	-	10.5	-	nC
Q <sub>gs</sub>	Gate-source charge		-	2	-	nC
Q <sub>gd</sub>	Gate-drain charge		-	7.5	-	nC

1. Time related is defined as a constant equivalent capacitance giving the same charging time as C<sub>oss</sub> when V<sub>DS</sub> increases from 0 to 80% V<sub>DSS</sub>
2. Energy related is defined as a constant equivalent capacitance giving the same stored energy as C<sub>oss</sub> when V<sub>DS</sub> increases from 0 to 80% V<sub>DSS</sub>

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 400 \text{ V}, I_D = 1.5 \text{ A}, R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ <i>(see Figure 18)</i>	-	16.5	-	ns
$t_r$	Rise time		-	15	-	ns
$t_{d(off)}$	Turn-off-delay time		-	36	-	ns
$t_f$	Fall time		-	21	-	ns

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		3	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				12	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 3 \text{ A}, V_{GS} = 0$	-		1.5	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 3 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 60 \text{ V}$ <i>(see Figure 20)</i>	-	242		ns
$Q_{rr}$	Reverse recovery charge		-	1.42		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	12		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 3 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 60 \text{ V}$ $T_J = 150^\circ\text{C}$ <i>(see Figure 20)</i>	-	373		ns
$Q_{rr}$	Reverse recovery charge		-	1.98		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	10.5		A

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

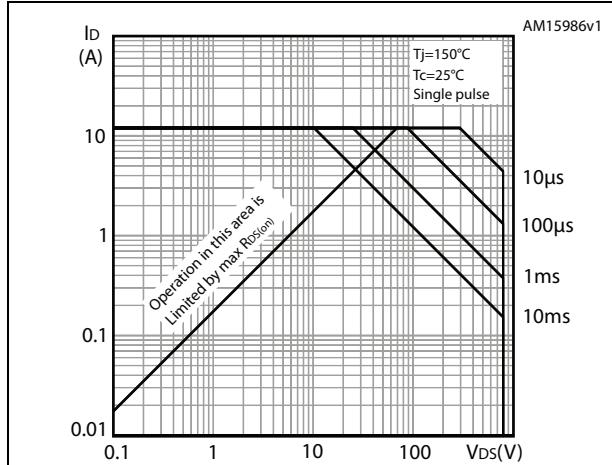
**Table 8. Gate-source Zener diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0$	30	-	-	V

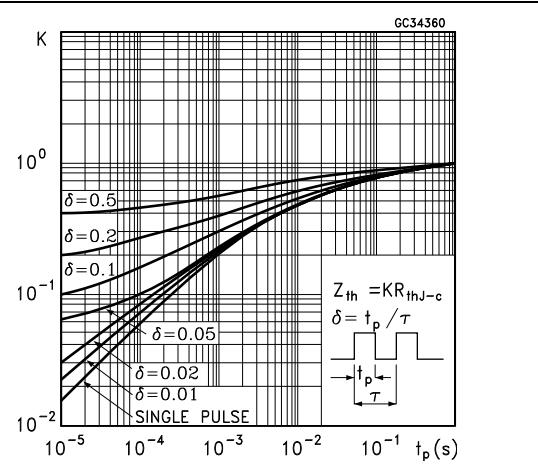
The built-in back-to-back Zener diodes have been specifically designed to enhance the ESD capability of the device. The Zener voltage is appropriate for efficient and cost-effective intervention to protect the device integrity. These integrated Zener diodes thus eliminate the need for external components.

## 2.1 Electrical characteristics (curves)

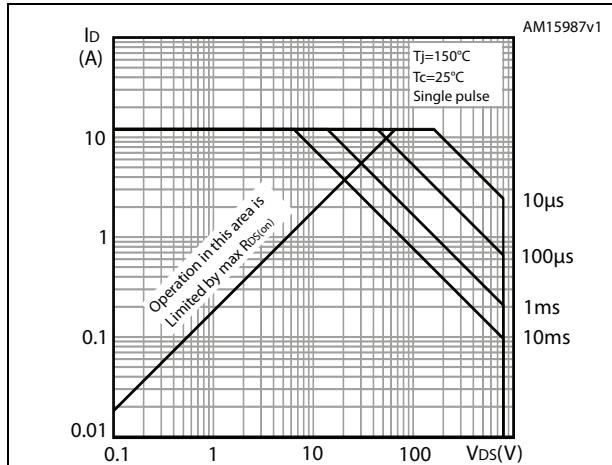
**Figure 2. Safe operating area for DPAK and IPAK**



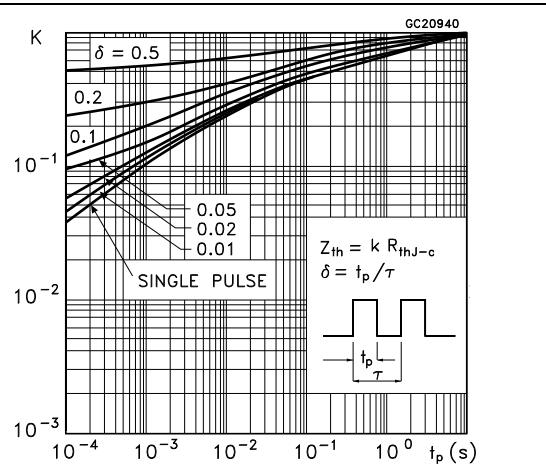
**Figure 3. Thermal impedance for DPAK and IPAK**



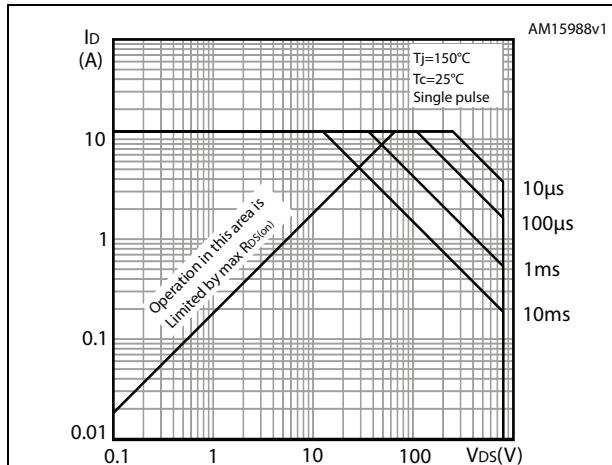
**Figure 4. Safe operating area for TO-220FP**



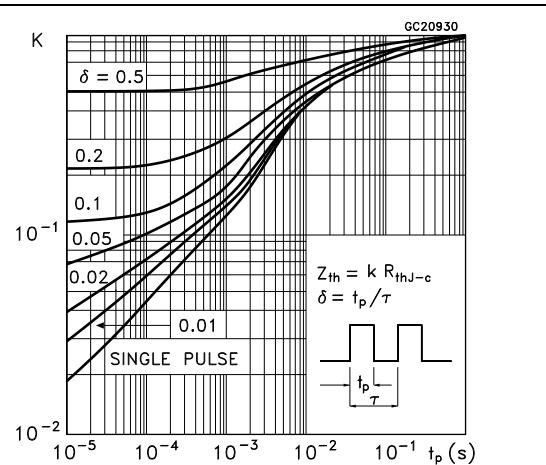
**Figure 5. Thermal impedance for TO-220FP**

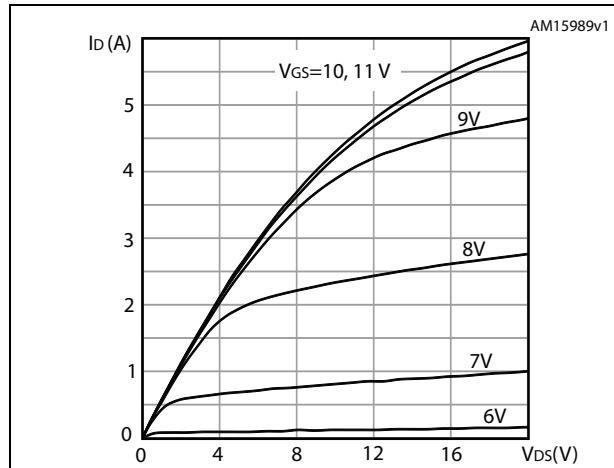
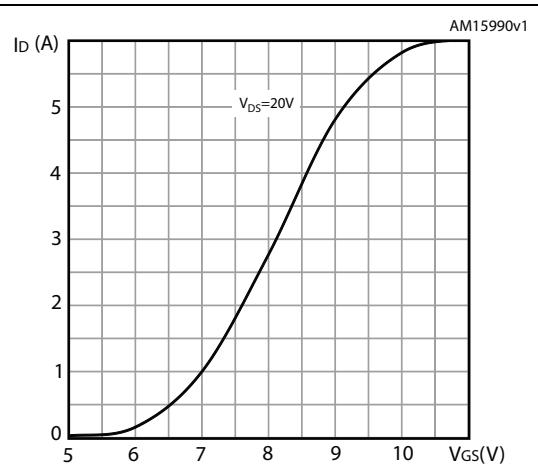
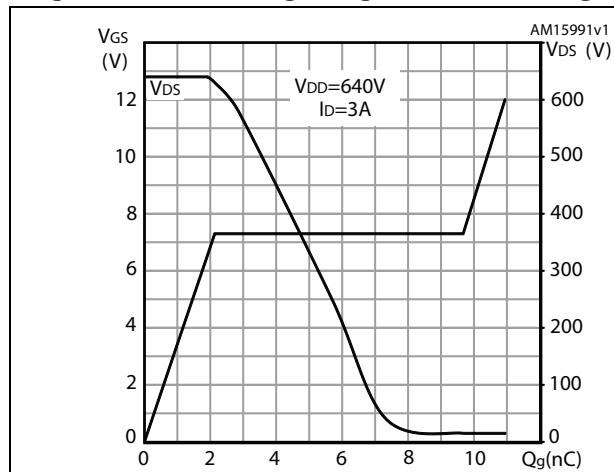
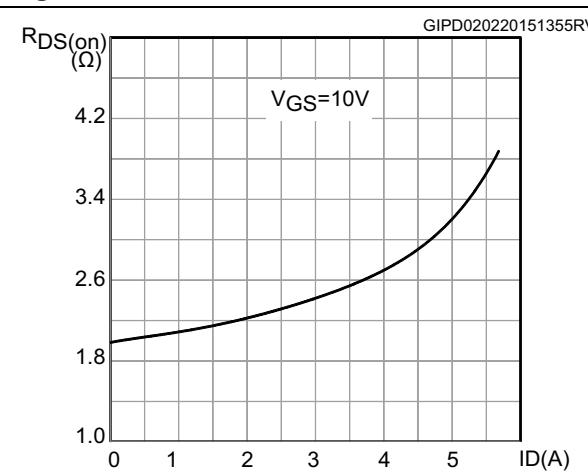
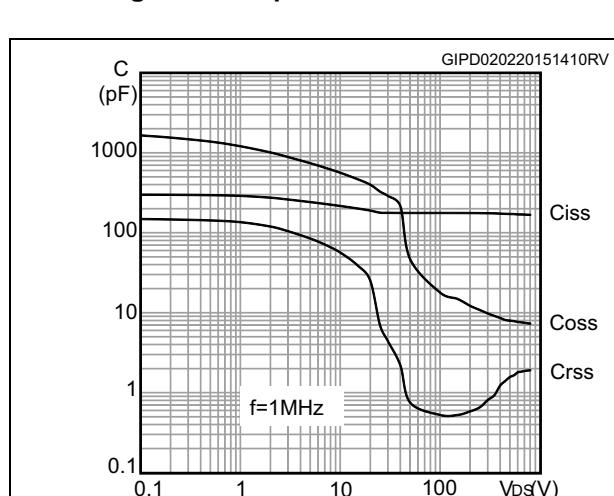
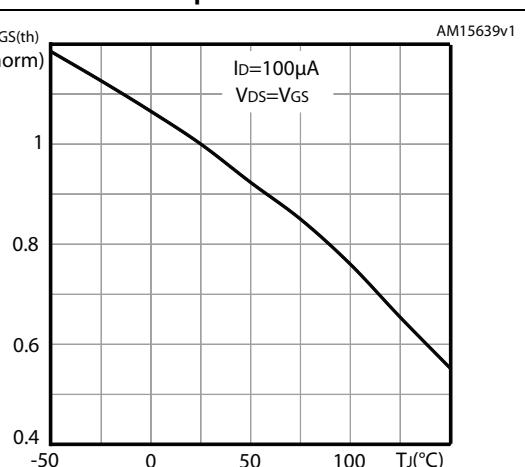


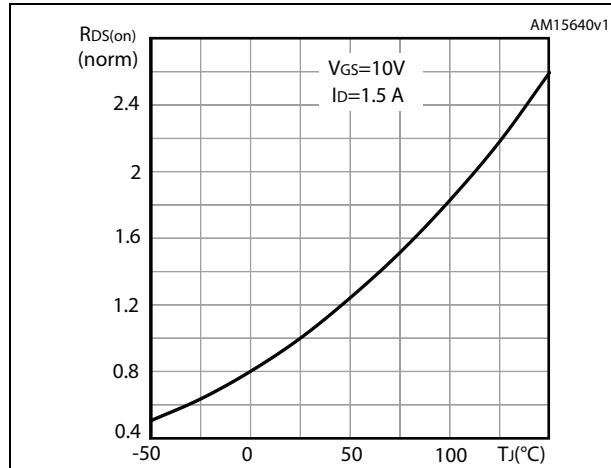
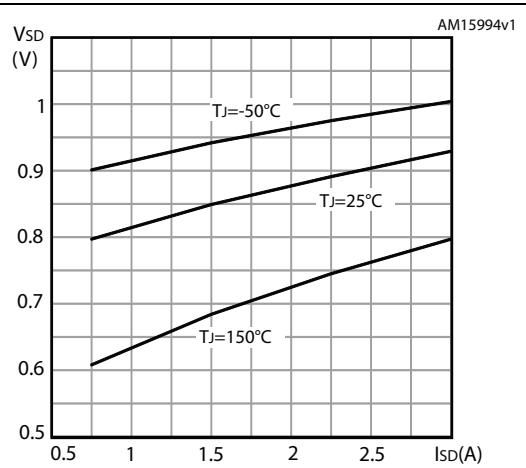
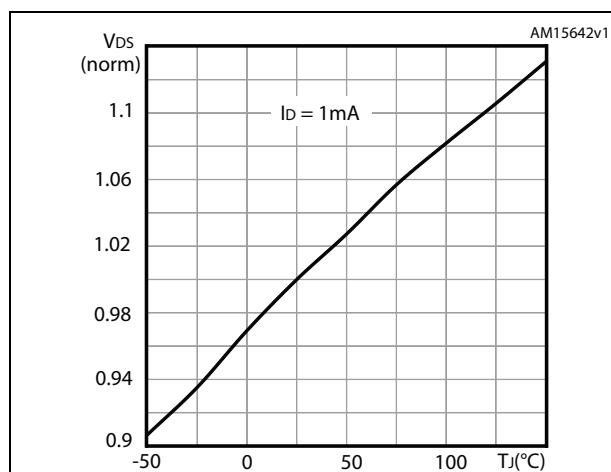
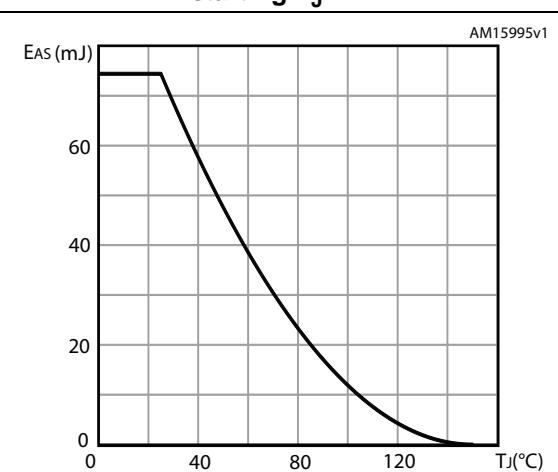
**Figure 6. Safe operating area for TO-220**



**Figure 7. Thermal impedance for TO-220**

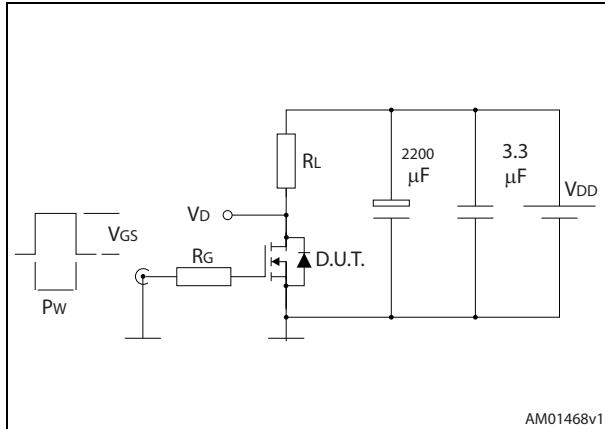


**Figure 8. Output characteristics****Figure 9. Transfer characteristics****Figure 10. Gate charge vs gate-source voltage****Figure 11. Static drain-source on-resistance****Figure 12. Capacitance variations****Figure 13. Normalized gate threshold voltage vs temperature**

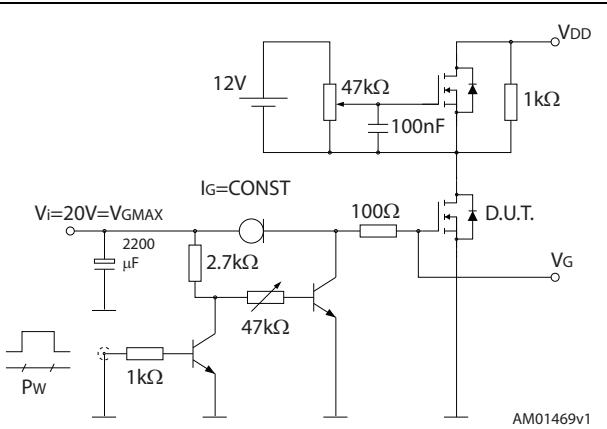
**Figure 14. Normalized on-resistance vs temperature****Figure 15. Source-drain diode forward characteristics****Figure 16. Normalized  $V_{DS}$  vs temperature****Figure 17. Maximum avalanche energy vs. starting  $T_J$** 

### 3 Test circuits

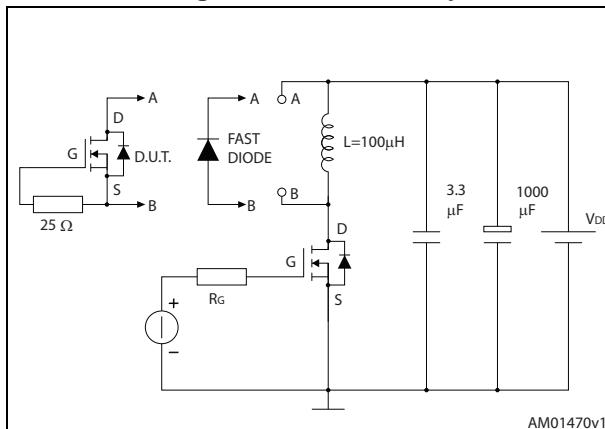
**Figure 18. Switching times test circuit for resistive load**



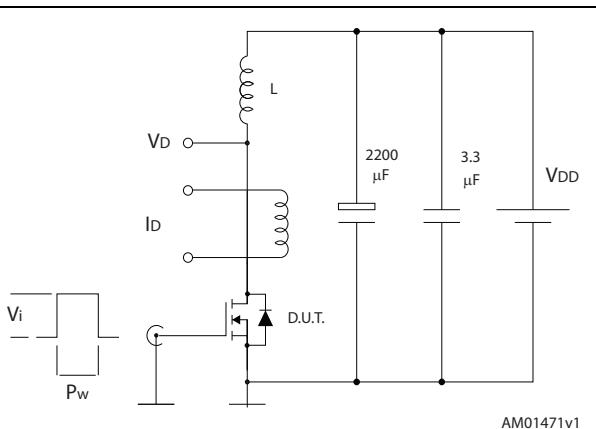
**Figure 19. Gate charge test circuit**



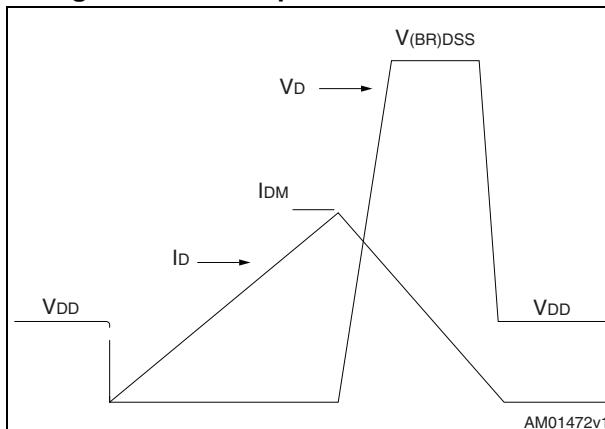
**Figure 20. Test circuit for inductive load switching and diode recovery times**



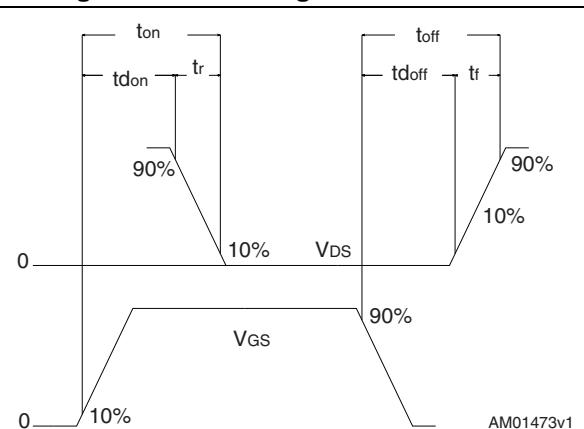
**Figure 21. Unclamped inductive load test circuit**



**Figure 22. Unclamped inductive waveform**



**Figure 23. Switching time waveform**

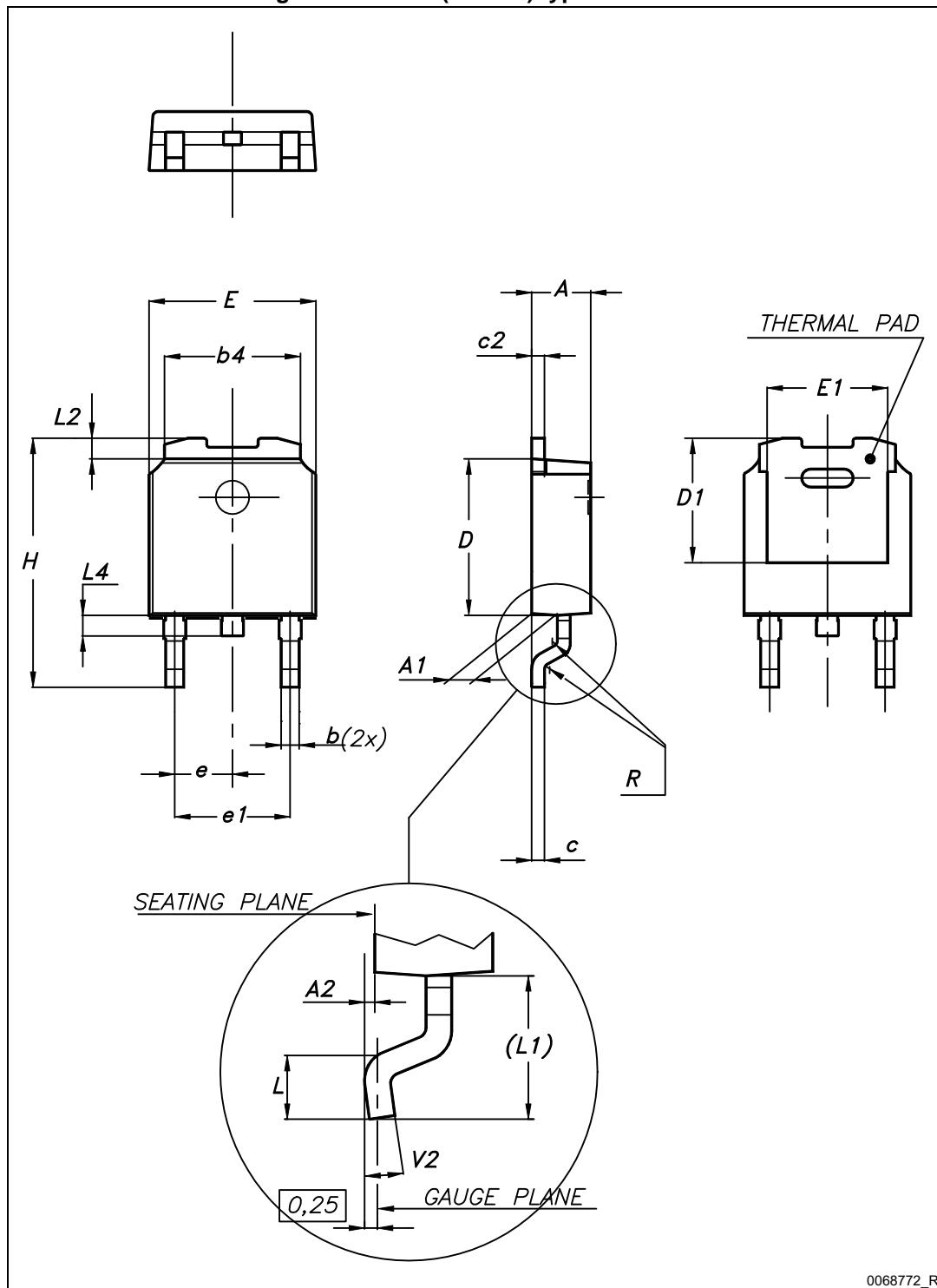


## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

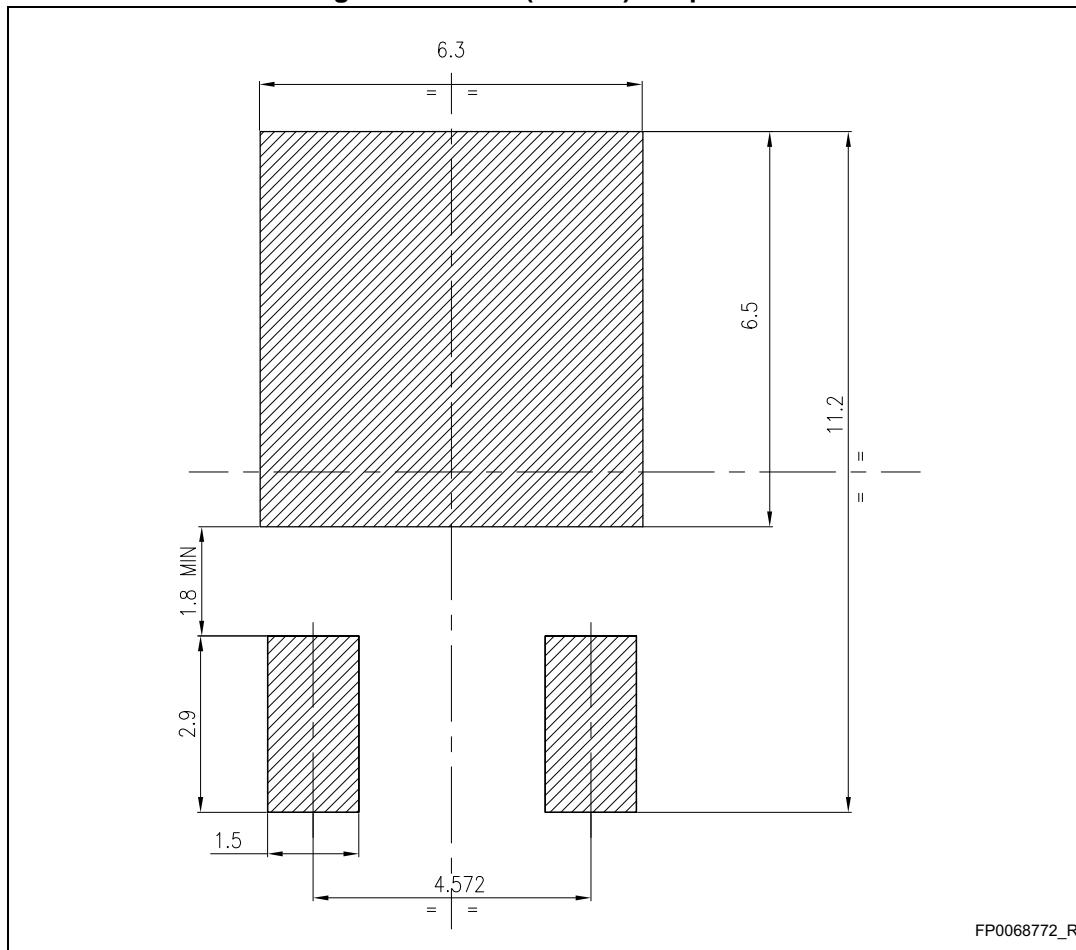
## 4.1 DPAK(TO-252), package information

Figure 24. DPAK (TO-252) type A outline



**Figure 25. DPAK (TO-252) mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1.00		1.50
L1		2.80	
L2		0.80	
L4	0.60		1.00
R		0.20	
V2	0°		8°

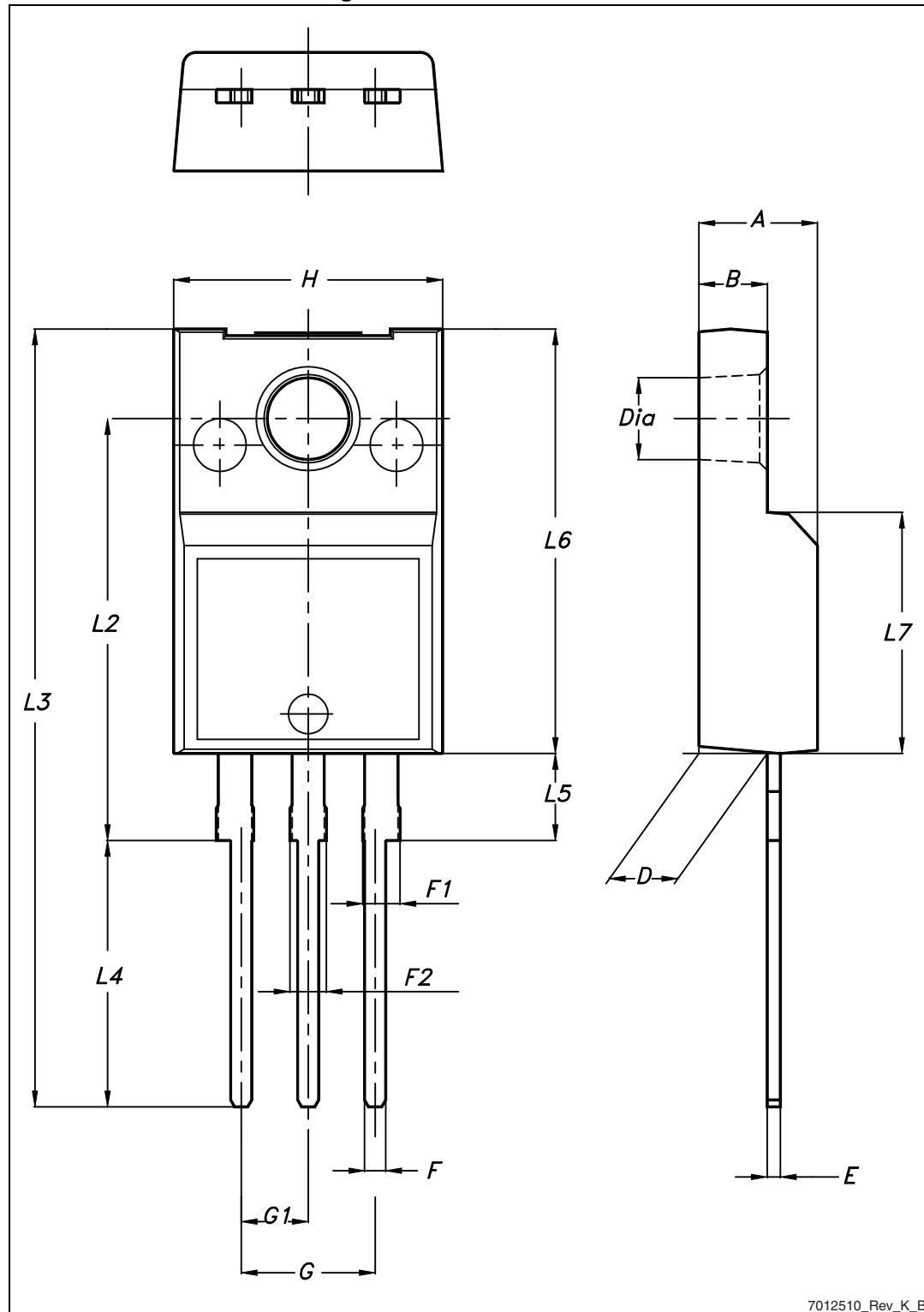
**Figure 26. DPAK (TO-252) footprint (a)**

FP0068772\_R

a. All dimensions are in millimeters

## 4.2 TO-220FP, package information

Figure 27. TO-220FP outline

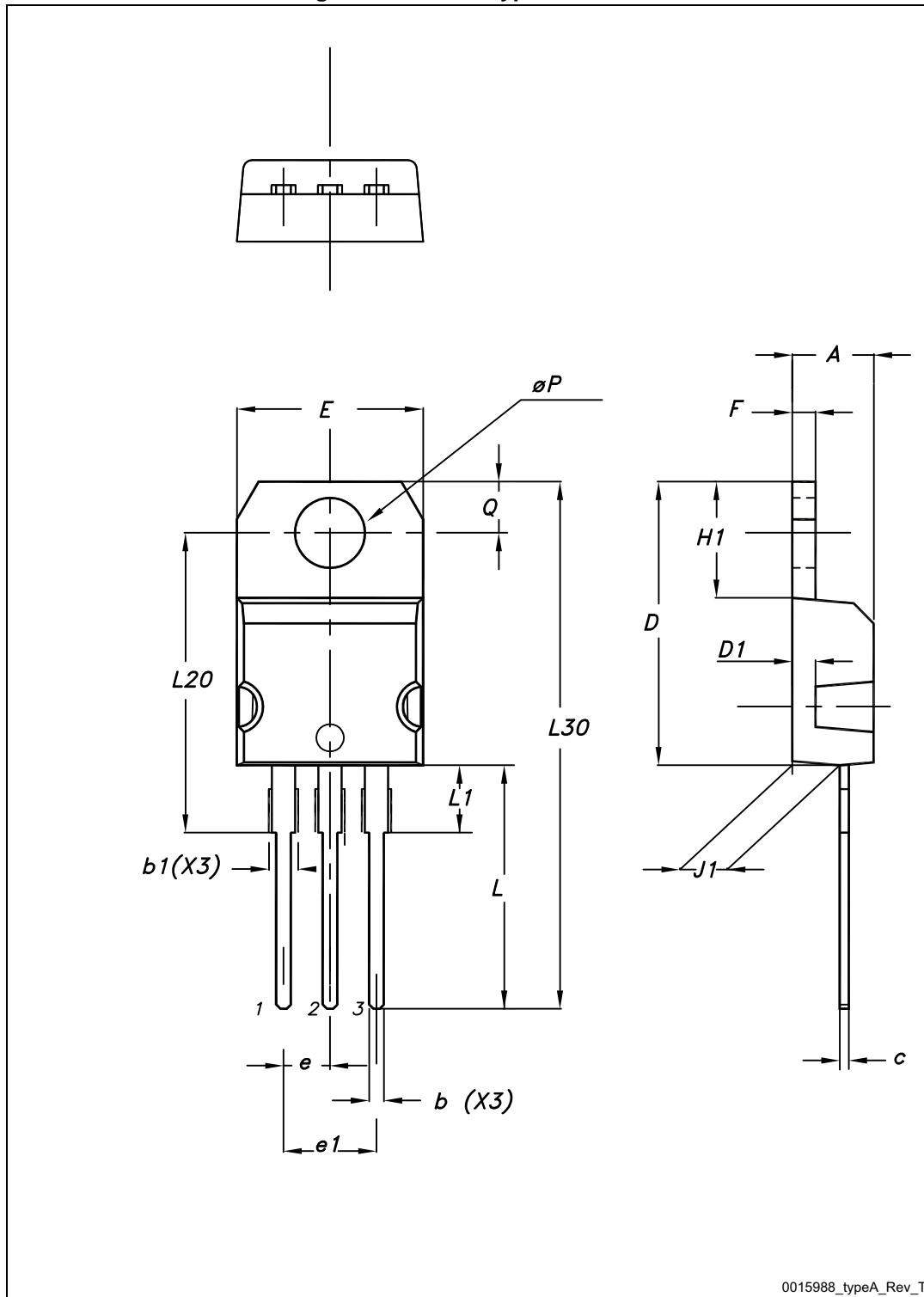


**Table 9. TO-220FP mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

### 4.3 TO-220, package information

Figure 28. TO-220 type A outline

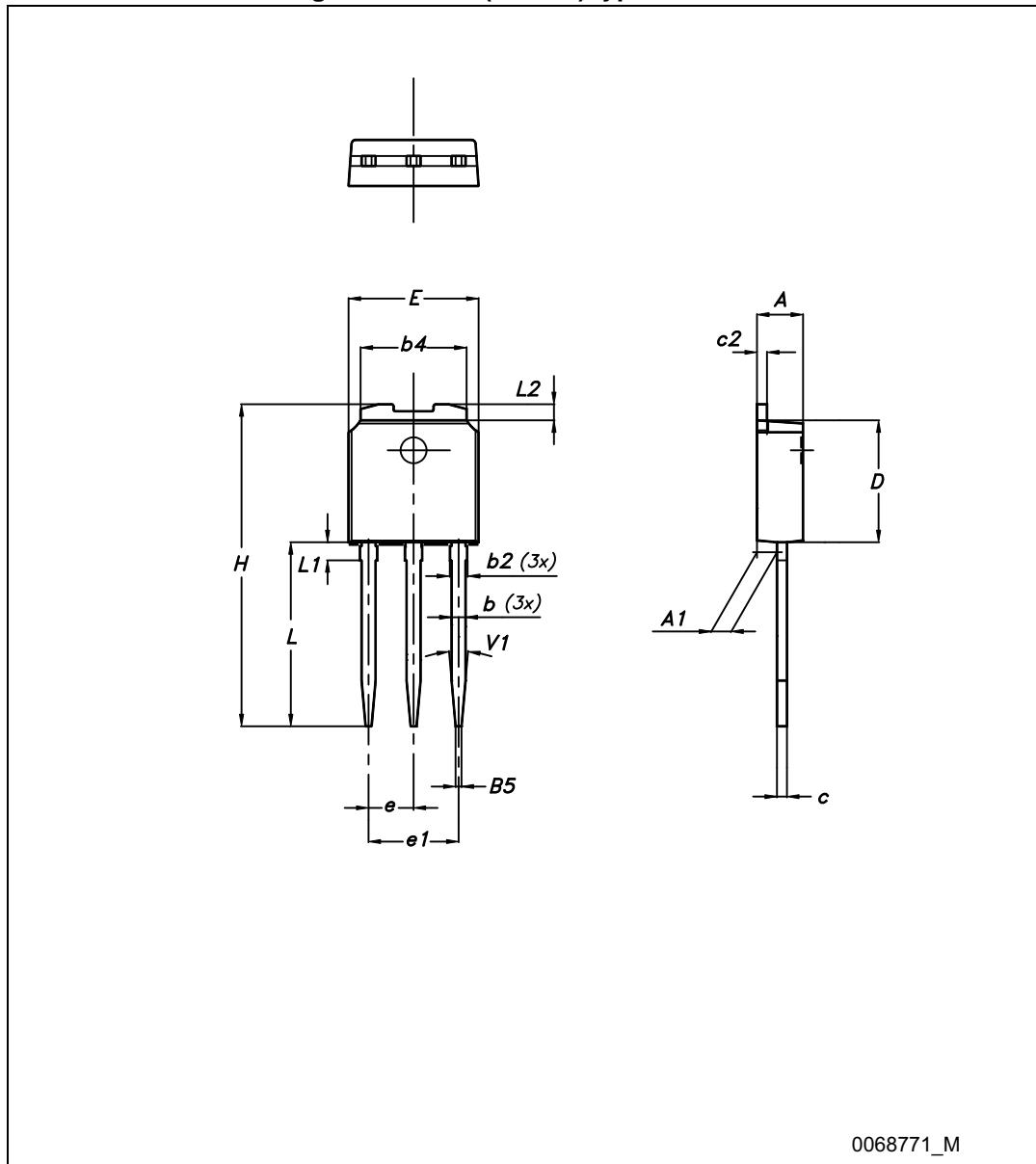


**Table 10. TO-220 type A mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

## 4.4 IPAK(TO-251), package information

Figure 29. IPAK (TO-251) type A outline



**Table 11. IPAK (TO-251) type A mechanical data**

DIM	mm.		
	min.	typ.	max.
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
B5		0.30	
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.28	
e1	4.40		4.60
H		16.10	
L	9.00		9.40
L1	0.80		1.20
L2		0.80	1.00
V1		10°	

## 5 Packaging mechanical data

Table 12. DPAK (TO-252) tape and reel mechanical data

Tape			Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.		Min.	Max.
A0	6.8	7	A		330
B0	10.4	10.6	B	1.5	
B1		12.1	C	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	T		22.4
K0	2.55	2.75			
P0	3.9	4.1		Base qty.	2500
P1	7.9	8.1		Bulk qty.	2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			

Figure 30. Tape for DPAK (TO-252)

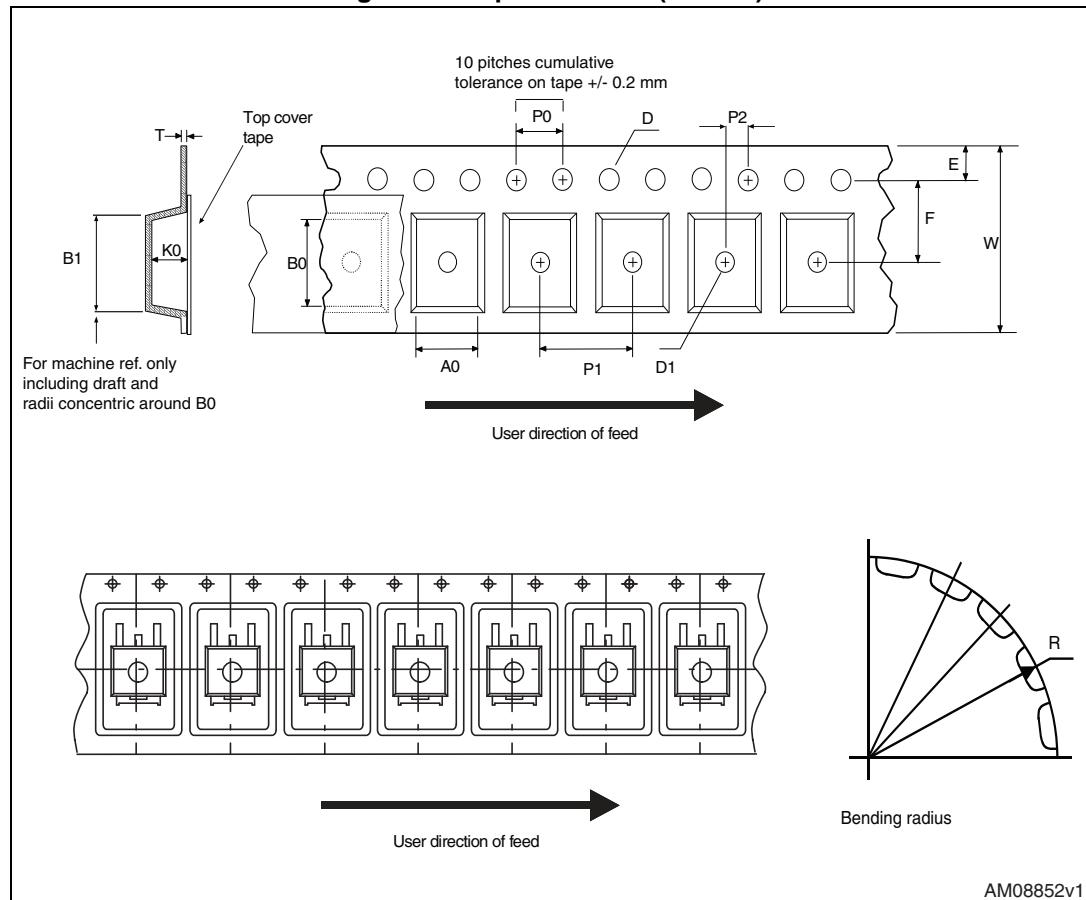
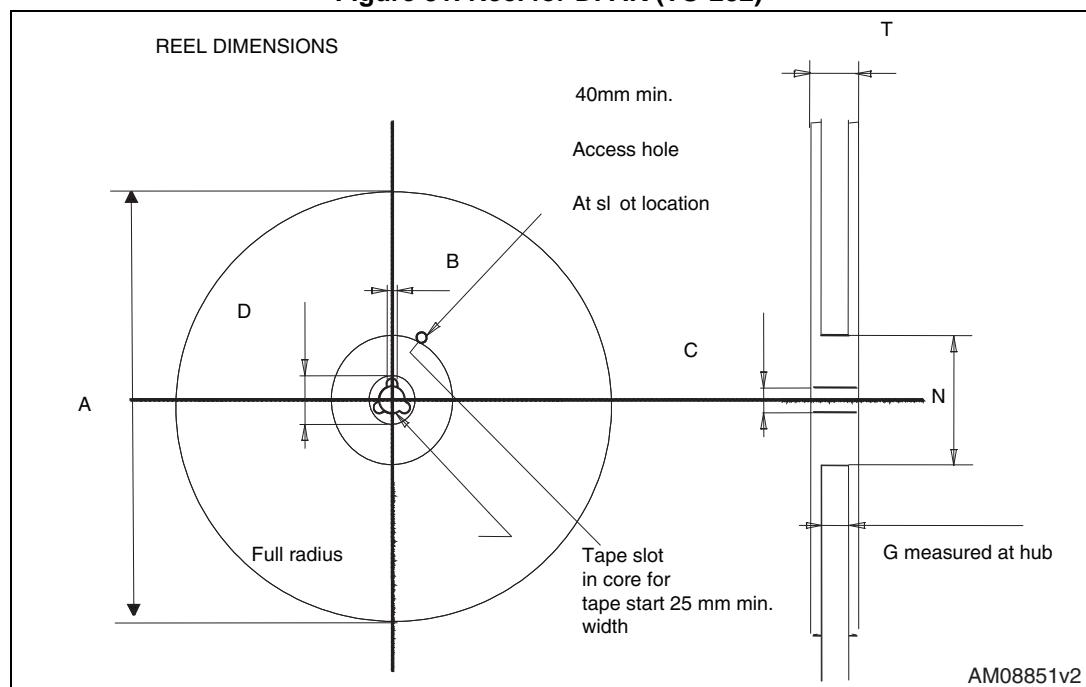


Figure 31. Reel for DPAK (TO-252)



## 6 Revision history

Table 13. Document revision history

Date	Revision	Changes
09-Aug-2013	1	First release
13-Dec-2013	2	<ul style="list-style-type: none"><li>– Added: IPAK package</li><li>– Added: <a href="#">Table 11</a> and <a href="#">Figure 29</a></li><li>– Minor text changes</li></ul>
04-Feb-2015	3	<ul style="list-style-type: none"><li>– Updated title and description in cover page.</li><li>– Updated <a href="#">Table 2.: Absolute maximum ratings</a>, <a href="#">Table 5.: Dynamic</a> and <a href="#">Table 7.: Source drain diode</a>.</li><li>– Updated <a href="#">4: Package information</a> and <a href="#">5: Packaging mechanical data</a>.</li><li>– Minor text changes.</li></ul>

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[DMN3404LQ-7](#) [NTE6400](#) [SQJ402EP-T1-GE3](#) [2SK2614\(TE16L1,Q\)](#) [2N7002KW-FAI](#) [DMN1017UCP3-7](#) [EFC2J004NUZTDG](#) [ECH8691-](#)  
[TL-W](#) [FCAB21350L1](#) [P85W28HP2F-7071](#) [DMN1053UCP4-7](#) [NTE221](#) [NTE2384](#) [NTE2903](#) [NTE2941](#) [NTE2945](#) [NTE2946](#) [NTE2960](#)  
[NTE2967](#) [NTE2969](#) [NTE2976](#) [NTE455](#) [NTE6400A](#) [NTE2910](#) [NTE2916](#) [NTE2956](#) [NTE2911](#) [DMN2080UCB4-7](#) [TK10A80W,S4X\(S](#)  
[SSM6P69NU,LF](#) [DMP22D4UFO-7B](#)